

Search Notes

Application/Control No.

10/725,139

Examiner

Elias Desta

Applicant(s)/Patent under
Reexamination

SATO ET AL.

Art Unit

2857

SEARCHED

Class	Subclass	Date	Examiner
702	182,183,1 89,190	7/20/2006	E.D
118	723e	7/20/2006	E.D
156	345.24	7/20/2006	E.D
	345.25		
216	59-61, 67	7/20/2006	E.D
	72-58		
438	738-751	7/20/2006	E.D

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Method of search: EAST, GOOGLE, YAHOO, IEEE Explore, CRC and Semiconductor Process Text book	7/20/2006	E.D
Consulted: Tod Swann, 101 panel; Hassanzader Parviz, class 216, au: 1763	1/31/2006	E.D
Text or key word searches: see attachments	7/20/2006	E.D